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Report No.: SZEM160300168002
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FCC REPORT

Application No:	SZEM1603001680RG
Applicant:	Haier Telecom (Qingdao) Co., Ltd.
Manufacturer:	Haier Telecom (Qingdao) Co., Ltd.
Factory:	Haier Telecom (Qingdao) Co., Ltd.
Product Name:	Mobilephone
Model No.(EUT):	V4
Trade Mark:	Haier
FCC ID:	SG7201603V4
Standards:	47 CFR Part 2(2014) 47 CFR Part 22 subpart H(2014) 47 CFR Part 24 subpart E(2014)
Test Method:	FCC KDB 971168 D01 Power Meas License Digital Systems v02r02
Date of Receipt:	2016-04-05
Date of Test:	2016-04-22
Date of Issue:	2016-06-01

Test Result:	PASS *
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* In the configuration tested, the EUT detailed in this report complied with the standards specified above.

Authorized Signature:



Jack Zhang
EMC Laboratory Manager

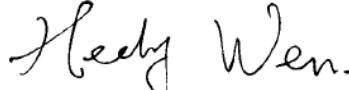
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2 Version

Revision Record				
Version	Chapter	Date	Modifier	Remark
00		2016-06-01		Original

Authorized for issue by:			
Tested By		 (David Chen) /Project Engineer	2016-04-22
Prepared By		 (Hedy Wen) /Clerk	2016-06-01
Checked By		 (Jim Huang) /Reviewer	2016-06-01

3 Test Summary

3.1 Cellular Band (824-849 MHz Paired With 869-894 MHz)

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046, §22.913, §24.232 §27.50	FCC: ERP ≤ 2 W.	Section 1 of Appendix B	PASS
Peak-Average Ratio	§24.232 §27.50	≤13dB	Section 2 of Appendix B	PASS
Modulation Characteristics	§2.1047	Digital modulation	Section 3 of Appendix B	PASS
Bandwidth	§2.1049(h), §22.917, §24.238 §27.53	OBW:No limit EBW: No limit	Section 4 of Appendix B	PASS
Band Edge Compliance	§2.1051, §22.917, §24.238 §27.53	≤ -13dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.	Section 5 of Appendix B	PASS
Spurious emissions at antenna terminals	§2.1051, §22.917, §24.238 §27.53	FCC: ≤ -13dBm/100 kHz, from 9 kHz to 10th harmonics but outside authorized operating frequency ranges.	Section 6 of Appendix B	PASS
Field strength of spurious radiation	§2.1051, §22.917, §24.238 §27.53	FCC: ≤ -13dBm/100 kHz,	Section 7 of Appendix B	PASS
Frequency stability	§2.1055, §22.355, §24.235 §27.54	≤ ±2.5ppm.	Section 8 of Appendix B	PASS

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5 General Information

5.1 Client Information

Applicant:	Haier Telecom (Qingdao) Co., Ltd.
Address of Applicant:	No.1 Haier Road, Hi-tech Zone, Qingdao, 266101 P.R. China
Manufacturer:	Haier Telecom (Qingdao) Co., Ltd.
Address of Manufacturer:	No.1 Haier Road, Hi-tech Zone, Qingdao, 266101 P.R. China
Factory:	Haier Telecom (Qingdao) Co., Ltd.
Address of Factory:	No.1 Haier Road, Hi-tech Zone, Qingdao, 266101 P.R. China

5.2 General Description of EUT

Product Name:	Mobilephone
Model No.:	V4
Trade Mark:	Haier
Sample Type:	Portable production
Antenna Type:	Monopole
Antenna Gain:	GSM 850: -6.47dBi, GSM 1900: -3.85dBi, WCDMA B2: -3.85dBi, WCDMA B4: -8.21dBi, WCDMA B5: -6.47dBi, LTE B2: -3.85dBi, LTE B4: -6.09dBi, LTE B7: -5.17dBi, LTE B17: -8.53dBi.

5.3 Test Mode

Test Mode	Test Modes Description
GSM/TM1	GSM system, GSM/GPRS/EGPRS, GMSK modulation
GSM/TM2	GSM system, EGPRS, 8PSK modulation
UMTS/TM1	UMTS system, WCDMA, QPSK modulation
LTE/TM1	LTE system, QPSK modulation
LTE/TM2	LTE system, 16QAM modulation

NOTE: The test mode(s) are selected according to relevant radio technology specifications.

5.4 Test Environment

Environment Parameter	Selected Values During Tests	
Relative Humidity	52%	
Atmospheric Pressure:	1015Pa	
Temperature	TN	25 °C
Voltage :	VL	3.45V
	VN	3.8V
	VH	4.35V

NOTE: VL= lower extreme test voltage

VN= nominal voltage

VH= upper extreme test voltage

TN= normal temperature

5.5 Test Frequency

Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
GSM850	TX	Channel 128	Channel 192	Channel 251
		824.2MHz	836.6MHz	848.8MHz
	RX	Channel 128	Channel 192	Channel 251
		869.2MHz	881.6MHz	893.8MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
GSM1900	TX	Channel 512	Channel 661	Channel 810
		1850.2MHz	1880.0MHz	1909.8MHz
	RX	Channel 512	Channel 661	Channel 810
		1930.2 MHz	1960.0 MHz	1989.8 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
WCDMA850	TX	Channel 4132	Channel 4182	Channel 4233
		826.4MHz	836.4MHz	846.6MHz
	RX	Channel 4357	Channel 4407	Channel 4458
		871.4 MHz	881.4 MHz	891.6 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
WCDMA1700	TX	Channel 1312	Channel 1413	Channel 1513
		1712.4MHz	1732.6 MHz	1752.6 MHz
	RX	Channel 1537	Channel 1638	Channel 1738
		2112.4 MHz	2132.6 MHz	2152.6 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
WCDMA1900	TX	Channel 9262	Channel 9400	Channel 9538
		1852.4 MHz	1880.0 MHz	1907.6 MHz
	RX	Channel 9662	Channel 9800	Channel 9938
		1932.4 MHz	1960.0 MHz	1987.6 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND 2 1.4MHz	TX	Channel 18607	Channel 18900	Channel 19193
		1850.7 MHz	1880 MHz	1909.3 MHz
	RX	Channel 607	Channel 900	Channel 1193
		1930.7 MHz	1960 MHz	1989.3 MHz

Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND 2 3MHz	TX	Channel 18615	Channel 18900	Channel 19185
		1851.5 MHz	1880 MHz	1908.5 MHz
	RX	Channel 615	Channel 900	Channel 1185
		1931.5 MHz	1960 MHz	1988.5 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND 2 5MHz	TX	Channel 18625	Channel 18900	Channel 19175
		1852.5 MHz	1880 MHz	1907.5 MHz
	RX	Channel 625	Channel 900	Channel 1175
		1932.5 MHz	1960 MHz	1987.5 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND 2 10MHz	TX	Channel 18650	Channel 18900	Channel 19150
		1855 MHz	1880 MHz	1905 MHz
	RX	Channel 650	Channel 900	Channel 1150
		1935 MHz	1960 MHz	1985 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND 2 15MHz	TX	Channel 18675	Channel 18900	Channel 19125
		1857.5 MHz	1880 MHz	1902.5 MHz
	RX	Channel 675	Channel 900	Channel 1125
		1937.5 MHz	1960 MHz	1982.5 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND 2 20MHz	TX	Channel 18700	Channel 18900	Channel 19100
		1860 MHz	1880 MHz	1900 MHz
	RX	Channel 700	Channel 900	Channel 1100
		1940 MHz	1960 MHz	1980 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND 4 1.4MHz	TX	Channel 19957	Channel 20175	Channel 20393
		1710.7 MHz	1732.5 MHz	1754.3 MHz
	RX	Channel 1957	Channel 2175	Channel 2393
		2110.7 MHz	2132.5 MHz	2154.3 MHz

Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND 4 3MHz	TX	Channel 19965	Channel 20175	Channel 20385
		1711.5 MHz	1732.5 MHz	1753.5 MHz
	RX	Channel 1965	Channel 2175	Channel 2385
		2111.5 MHz	2132.5 MHz	2153.5 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND 4 5MHz	TX	Channel 19975	Channel 20175	Channel 20375
		1712.5 MHz	1732.5 MHz	1752.5 MHz
	RX	Channel 1975	Channel 2175	Channel 2375
		2112.5 MHz	2132.5 MHz	2152.5 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND 4 10MHz	TX	Channel 20000	Channel 20175	Channel 20350
		1715 MHz	1732.5 MHz	1750 MHz
	RX	Channel 2000	Channel 2175	Channel 2350
		2115 MHz	2132.5 MHz	2150 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND 4 15MHz	TX	Channel 20025	Channel 20175	Channel 20325
		1717.5 MHz	1732.5 MHz	1747.5 MHz
	RX	Channel 2025	Channel 2175	Channel 2325
		2117.5 MHz	2132.5 MHz	2147.5 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND 4 20MHz	TX	Channel 20050	Channel 20175	Channel 20300
		1720 MHz	1732.5 MHz	1745 MHz
	RX	Channel 2050	Channel 2175	Channel 2300
		2120 MHz	2132.5 MHz	2145 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND 7 5MHz	TX	Channel 20775	Channel 21100	Channel 21425
		2502.5 MHz	2535 MHz	2567.5 MHz
	RX	Channel 2775	Channel 3100	Channel 3425
		2622.5 MHz	2630 MHz	2687.5 MHz

Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND 7 10MHz	TX	Channel 20800	Channel 21100	Channel 21400
		2505 MHz	2535 MHz	2565 MHz
	RX	Channel 2800	Channel 3100	Channel 3400
		2625 MHz	2630 MHz	2685 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND 7 15MHz	TX	Channel 20825	Channel 21100	Channel 21375
		2507.5 MHz	2535 MHz	2562.5 MHz
	RX	Channel 2825	Channel 3100	Channel 3375
		2627.5 MHz	2630 MHz	2682.5 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND 7 20MHz	TX	Channel 20850	Channel 21100	Channel 21350
		2510 MHz	2535 MHz	2560 MHz
	RX	Channel 2850	Channel 3100	Channel 3350
		2630 MHz	2630 MHz	2680 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND 17 5MHz	TX	Channel 23755	Channel 23790	Channel 23825
		706.5 MHz	710 MHz	713.5 MHz
	RX	Channel 5755	Channel 5790	Channel 5825
		736.5 MHz	740 MHz	743.5 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
LTE BAND 17 10MHz	TX	Channel 23780	Channel 23790	Channel 23800
		709 MHz	710 MHz	711 MHz
	RX	Channel 5780	Channel 5790	Channel 5800
		739 MHz	740 MHz	741 MHz

5.6 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen Branch E&E Lab,
No. 1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, Guangdong, China.
518057.
Tel: +86 755 2601 2053 Fax: +86 755 2671 0594
No tests were sub-contracted.

5.7 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

- CNAS (No. CNAS L2929)**

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

- A2LA (Certificate No. 3816.01)**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

- VCCI**

The 10m Semi-anechoic chamber and Shielded Room of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-823, R-4188, T-1153 and C-2383 respectively.

- FCC – Registration No.: 556682**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No.: 556682.

- Industry Canada (IC)**

Two 3m Semi-anechoic chambers and the 10m Semi-anechoic chamber of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-1, 4620C-2, 4620C-3.

5.8 Deviation from Standards

None.

5.9 Abnormalities from Standard Conditions

None.

5.10 Other Information Requested by the Customer

None.

5.11 Technical Specification

Characteristics	Description	
Radio System Type	<input checked="" type="checkbox"/> GSM	
	<input checked="" type="checkbox"/> UMTS	
	<input checked="" type="checkbox"/> LTE	
Supported Frequency Range	GSM850	Transmission (TX): 824 to 849 MHz Receiving (RX): 869 to 894 MHz
	GSM1900	Transmission (TX): 1850 to 1910 MHz Receiving (RX): 1930 to 1990 MHz
	UMTS 850	Transmission (TX): 824 to 849 MHz Receiving (RX): 869 to 894 MHz
	UMTS 1700	Transmission (TX): 1710 to 1755 MHz Receiving (RX): 2110 to 2155 MHz
	UMTS 1900	Transmission (TX): 1850 to 1910 MHz Receiving (RX): 1930 to 1990 MHz
	LTE 700	Transmission (TX): 704 to 716 MHz Receiving (RX): 734 to 746 MHz
	LTE 1700	Transmission (TX): 1710 to 1755 MHz Receiving (RX): 2110 to 2155 MHz
	LTE 1900	Transmission (TX): 1850 to 1910 MHz Receiving (RX): 1930 to 1990 MHz
	LTE 2600	Transmission (TX): 2500 to 2570 MHz Receiving (RX): 2620 to 2690 MHz
Target TX Output Power	GSM850: 34dBm GSM1900: 31dBm UMTS850: 24dBm UMTS1700: 23.5dBm UMTS1900: 23.5dBm LTE700: 23dBm LTE1700: 24dBm LTE1900: 23dBm LTE2600: 23dBm	
Supported Channel Bandwidth	GSM system:	<input checked="" type="checkbox"/> 200 kHz
	UMTS system:	<input checked="" type="checkbox"/> 5 MHz
	LTE system	<input checked="" type="checkbox"/> 1.4 MHz; 3 MHz; 5 MHz; 10 MHz; 15 MHz; 20 MHz

Characteristics	Description	
Designation of Emissions (Note: the necessary bandwidth of which is the worst value from the measured occupied bandwidths for each type of channel bandwidth configuration.)	GSM850: GSM1900: UMTS850: UMTS1700: UMTS1900: LTE 700: LTE1700: LTE1900: LTE2600:	247KGXW 251KG7W 4M15F9W 4M15F9W 4M15F9W 4M51G7D;4M52W7D 9M00G7D;9M00W7D 1M12G7D;1M11W7D 2M69G7D;2M69W7D 4M51G7D;4M52W7D 9M00G7D;9M00W7D 13M4G7D;13M5W7D 17M9G7D;17M9W7D 1M12G7D;1M11W7D 2M69G7D;2M69W7D 4M51G7D;4M52W7D 9M00G7D;9M00W7D 13M4G7D;13M5W7D 17M9G7D;17M9W7D 4M51G7D;4M52W7D 9M00G7D;9M00W7D 13M4G7D;13M5W7D 17M9G7D;17M9W7D

6 Description of Tests

6.1 Conducted Output Power

Measurement Procedure:

The transmitter output was connected to a calibrated coaxial cable, attenuator and power meter, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The power output at the transmitter antenna port was determined by adding the value of the cable insertion loss to the power reading. The tests were performed at three frequencies (low channel, middle channel and high channel) and on the highest power levels, which can be setup on the transmitters.

Note: Reference test setup 1

6.2 Effective (Isotropic) Radiated Power of Transmitter

Measurement Procedure:

Below 1GHz test procedure as below:

- 1). The EUT was powered ON and placed on a 0.8m high table in the chamber. The antenna of the transmitter was extended to its maximum length.
- 2). The disturbance of the transmitter was maximized on the test receiver display by raising and lowering from 1m to 4m the receive antenna and by rotating through 360° the turntable. After the fundamental emission was maximized, a field strength measurement was made.
- 3). Steps 1) and 2) were performed with the EUT and the receive antenna in both vertical and horizontal polarization.
- 4). The transmitter was then removed and replaced with another antenna. The center of the antenna was approximately at the same location as the center of the transmitter.
- 5). A signal at the disturbance was fed to the substitution antenna by means of a non-radiating cable. With both the substitution and the receive antennas horizontally polarized, the receive antenna was raised and lowered to obtain a maximum reading at the test receiver. The level of the signal generator was adjusted until the measured field strength level in step 2) is obtained for this set of conditions.
- 6). The output power into the substitution antenna was then measured.
- 7). Steps 5) and 6) were repeated with both antennas polarized.
- 8). Calculate power in dBm by the following formula:

$$\text{ERP (dBm)} = \text{Pg(dBm)} - \text{cable loss (dB)} + \text{antenna gain (dBd)}$$

Where:

Pg is the generator output power into the substitution antenna.

Above 1GHz test procedure as below:

- 1). Different between above is the test site, change from Semi- Anechoic Chamber to fully Anechoic Chamber
- 2). Calculate power in dBm by the following formula:

$$\text{EIRP(dBm)} = \text{Pg(dBm)} - \text{cable loss (dB)} + \text{antenna gain (dBi)}$$

$$\text{EIRP} = \text{ERP} + 2.15 \text{dB}$$

Where:

Pg is the generator output power into the substitution antenna.

- 3). Test the EUT in the lowest channel, the middle channel the Highest channel
- 4). The radiation measurements are performed in X, Y, Z axis positioning. And found the X axis positioning which it is worse case, Only the test worst case mode is recorded in the report.
- 5). Repeat above procedures until all frequencies measured was complete.

Note: Reference test setup 2

6.3 Occupied Bandwidth

Measurement Procedure:

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel, middle channel and high channel).The span of the analyzer shall be set to capture all products of the modulation process, including the emission skirts. The resolution bandwidth shall be set to as close to 1 percent of the selected span as is possible without being below 1 percent. The video bandwidth shall be set to 3 times the resolution bandwidth. Video averaging is not permitted. Where practical, a sampling detector shall be used since a peak or, peak hold, may produce a wider bandwidth than actual. The trace data points are recovered and are directly summed in linear terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5 percent of the total is reached and that frequency recorded. The process is repeated for the highest frequency data points. This frequency is recorded. The span between the two recorded frequencies is the occupied bandwidth.

Note: Reference test setup 1

6.4 Band Edge at Antenna Terminals

Measurement Procedure:

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel and high channel).in the 1MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of 100kHz or 1% of the emission bandwidth of the fundamental emission of the transmitter may be employed. The EUT emission bandwidth is measured as the width of the signal between two points, outside of which all emission are attenuated at least 26dB below the transmitter power. The video bandwidth of the spectrum analyzer was set at thrice the resolution bandwidth. Detector Mode was set to peak or peak hold power.

Note: Reference test setup 1

6.5 Spurious And Harmonic Emissions at Antenna Terminal

Measurement Procedure:

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyzer, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel and high channel).The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. On any frequency outside a licensee's frequency block, the power of any emission shall be attenuated below the transmitter power (P) by at least $43 + 10 \log(P)$ dB. Compliance with these provisions is based on the use of measurement instrumentation employing a resolution bandwidth of 1 MHz or greater. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

Note: Reference test setup 1

6.6 Peak-Average Ratio

Measurement Procedure:

A peak to average ratio measurement is performed at the conducted port of the EUT. For WCDMA signals, the spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth. The CCDF curve shows how much time the peak waveform spends at or above a given average power level. The percent of time the signal spends at or above the level defines the probability for that particular power level. For GSM signals, an average and a peak trace are used on a spectrum analyzer to determine the largest deviation between the average and the peak power of the EUT in a bandwidth greater than the emission bandwidth. The traces are generated with the spectrum analyzer set to zero span mode.

Note: Reference test setup 1

6.7 Field Strength of Spurious Radiation

Measurement Procedure:

Below 1GHz test procedure as below:

- 1). The EUT was powered ON and placed on a 80cm high table in the chamber. The antenna of the transmitter was extended to its maximum length.
- 2). The disturbance of the transmitter was maximized on the test receiver display by raising and lowering from 1m to 4m (for the test frequency of below 30MHz, the antenna was tuned to heights 1 meter) the receive antenna and by rotating through 360° the turntable. After the fundamental emission was maximized, a field strength measurement was made.
- 3). Steps 1) and 2) were performed with the EUT and the receive antenna in both vertical and horizontal polarization.
- 4). The transmitter was then removed and replaced with another antenna. The center of the antenna was approximately at the same location as the center of the transmitter.
- 5). A signal at the disturbance was fed to the substitution antenna by means of a non-radiating cable. With both the substitution and the receive antennas horizontally polarized, the receive antenna was raised and lowered to obtain a maximum reading at the test receiver. The level of the signal generator was adjusted until the measured field strength level in step 2) is obtained for this set of conditions.
- 6). The output power into the substitution antenna was then measured.
- 7). Steps 5) and 6) were repeated with both antennas polarized.
- 8) Calculate power in dBm by the following formula:

$$\text{ERP(dBm)} = \text{Pg(dBm)} - \text{cable loss (dB)} + \text{antenna gain (dBd)}$$

Where:

Pd is the dipole equivalent power, Pg is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to Pg [dBm] – cable loss [dB]. The calculated Pd levels are then compared to the absolute spurious emission limit of -13dBm which is equivalent to the required minimum attenuation of $43 + 10\log_{10}(\text{Power [Watts]})$.

Above 1GHz test procedure as below:

- 1) Different between above is the test site, change from Semi- Anechoic Chamber to fully Anechoic Chamber
- 2) Calculate power in dBm by the following formula:

$$\text{EIRP(dBm)} = \text{Pg(dBm)} - \text{cable loss (dB)} + \text{antenna gain (dBi)}$$

$$\text{EIRP} = \text{ERP} + 2.15\text{dB}$$

Where:

Pg is the generator output power into the substitution antenna.

3. Test the EUT in the lowest channel, the middle channel the Highest channel
4. The radiation measurements are performed in X, Y, Z axis positioning. And found the X axis positioning which it is worse case, Only the test worst case mode is recorded in the report.
5. Repeat above procedures until all frequencies measured was complete

Note: Reference test setup 3

6.8 Frequency Stability / Temperature Variation

Measurement Procedure:

Frequency stability testing is performed in accordance with the guidelines of ANSI/TIA-603-C-2004. The frequency stability of the transmitter is measured by:

- a.) **Temperature:** The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.
- b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

Specification – The frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block. The frequency stability of the transmitter shall be maintained within $\pm 0.00025\%$ ($\pm 2.5 \text{ ppm}$) of the center frequency.

Time Period and Procedure:

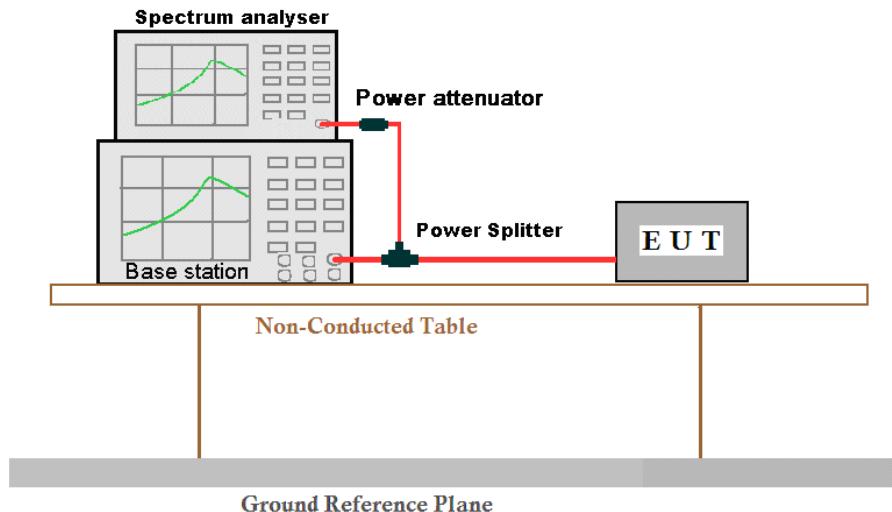
1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).

2. The equipment is turned on in a “standby” condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

Note: Reference test setup 4

6.9 Test Setups

6.9.1 Test Setup 1



6.9.2 Test Setup 2

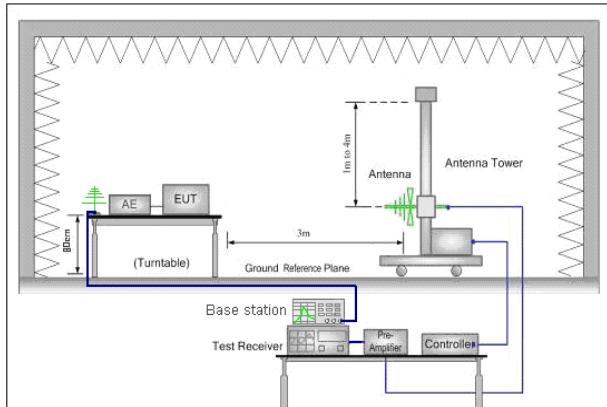


Figure 1. 30MHz to 1GHz

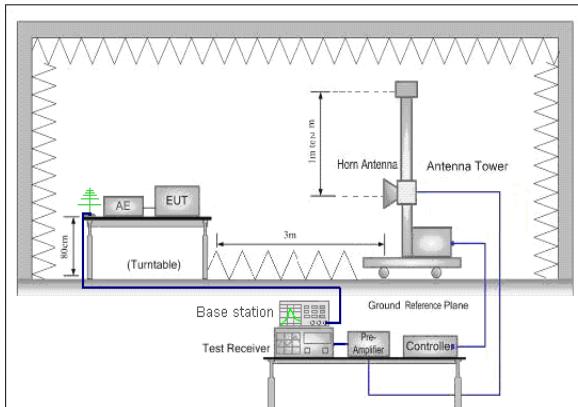


Figure 2. above 1GHz

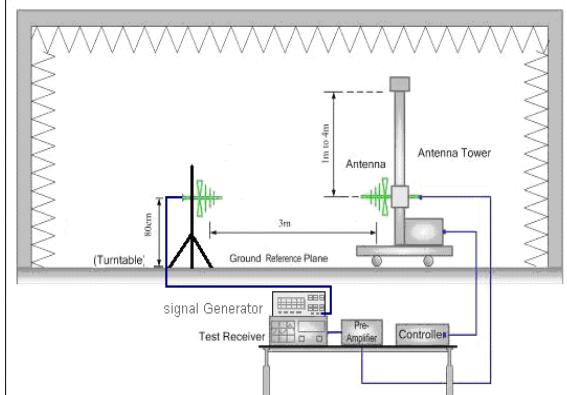


Figure 1. 30MHz to 1GHz

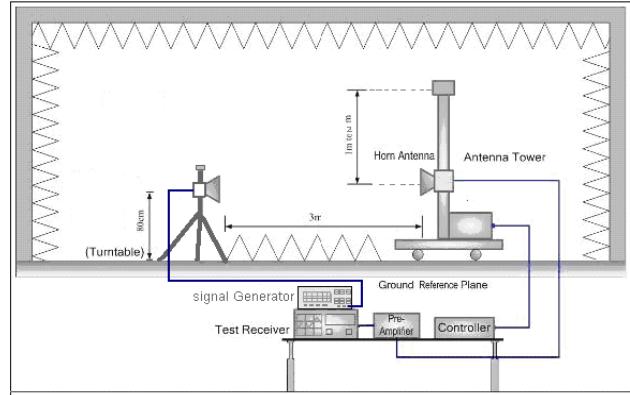


Figure 2. above 1GHz

6.9.3 Test Setup 3

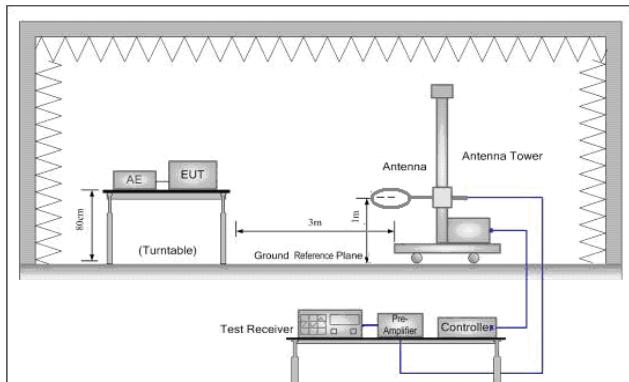


Figure 1. Below 30MHz

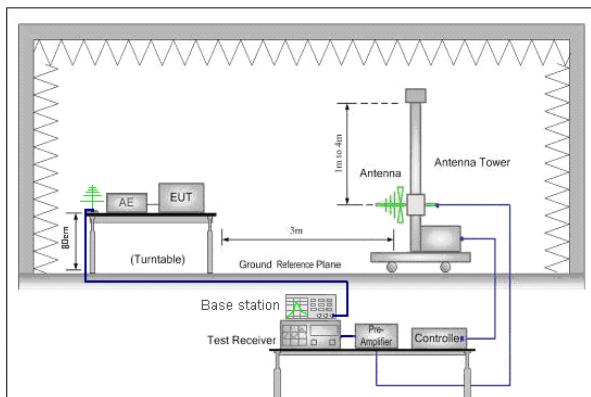


Figure 2. 30MHz to 1GHz

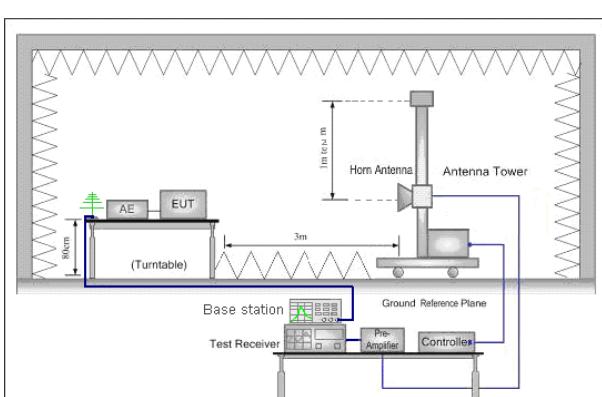


Figure 3. above 1GHz

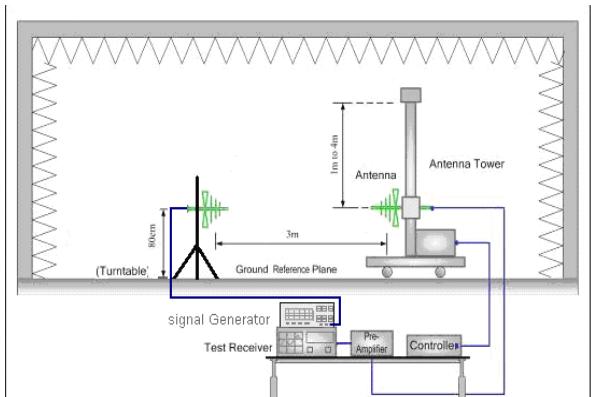


Figure 2. 30MHz to 1GHz

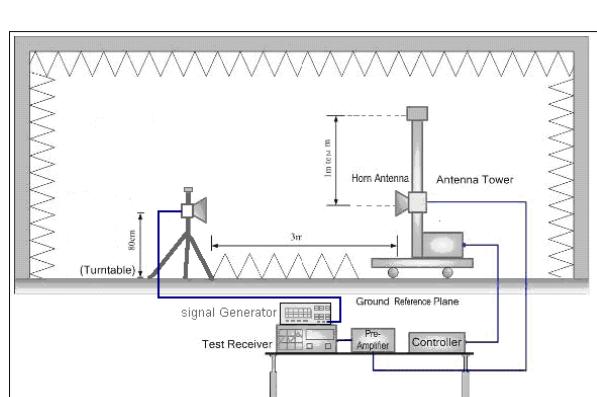
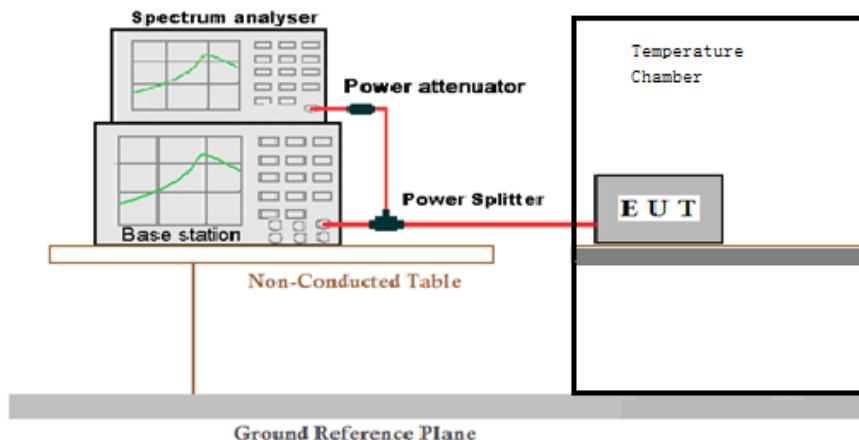


Figure 3. above 1GHz

6.9.4 Test Setup 4



6.10 Test Conditions

Test Case		Test Conditions		
Transmit Output Power Data	Average Power, Total	Test Environment	Ambient Climate & Rated Voltage	
		Test Setup	Test Setup 1	
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; LTE/TM1;LTE/TM2	
Peak-to-Average Ratio (if required)		Test Environment	Ambient Climate & Rated Voltage	
		Test Setup	Test Setup 1	
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; LTE/TM1;LTE/TM2	
Modulation Characteristics		Test Environment	Ambient Climate & Rated Voltage	
		Test Setup	Test Setup 1	
		RF Channels (TX)	M (M= middle channel)	
		Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1;	
Bandwidth	Occupied Bandwidth	Test Environment	Ambient Climate & Rated Voltage	
		Test Setup	Test Setup 1	
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; LTE/TM1;LTE/TM2	
	Emission Bandwidth (if required)	Test Environment	Ambient Climate & Rated Voltage	
		Test Setup	Test Setup 1	
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; LTE/TM1;LTE/TM2	

Band Edges Compliance	Test Environment	Ambient Climate & Rated Voltage
	Test Setup	Test Setup 1
	RF Channels (TX)	L, H (L= low channel, H= high channel)
	Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; LTE/TM1;LTE/TM2
Spurious Emission at Antenna Terminals	Test Environment	Ambient Climate & Rated Voltage
	Test Setup	Test Setup 1
	RF Channels (TX)	L, H (L= low channel, M= middle channel, H= high channel)
	Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; LTE/TM1;LTE/TM2
Field Strength of Spurious Radiation	Test Environment	Ambient Climate & Rated Voltage
	Test Setup	Test Setup 2
	Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; LTE/TM1;LTE/TM2 NOTE: If applicable, the EUT conf. that has maximum power density (based on the equivalent power level) is selected.
	RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
Frequency Stability	Test Env.	(1) -30 °C to +50 °C with step 10 °C at Rated Voltage; (2) VL, VN and VH of Rated Voltage at Ambient Climate.
	Test Setup	Test Setup 4
	RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
	Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; LTE/TM1;LTE/TM2

7 Main Test Instruments

RE in Chamber						
Item	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy-mm-dd)	Cal.Due date (yyyy-mm-dd)
1	3m Semi-Anechoic Chamber	ETS-LINDGREN	N/A	SEM001-01	2015-05-13	2016-05-13
2	EMI Test Receiver	Agilent Technologies	N9038A	SEM004-05	2015-10-09	2016-10-09
3	BiConiLog Antenna (26-3000MHz)	ETS-LINDGREN	3142C	SEM003-02	2014-11-15	2017-11-15
4	Double-ridged horn (1-18GHz)	ETS-LINDGREN	3117	SEM003-11	2015-10-17	2018-10-17
5	Horn Antenna (18-26GHz)	ETS-LINDGREN	3160	SEM003-12	2014-11-24	2017-11-24
6	Pre-amplifier (0.1-1300MHz)	Agilent Technologies	8447D	SEM005-01	2016-04-25	2017-04-25
7	Pre-Amplifier (0.1-26.5GHz)	Compliance Directions Systems Inc.	PAP-0126	SEM004-10	2015-10-17	2016-10-17
8	Band filter	Amindeon	82346	SEM023-01	N/A	N/A
9	Universal radio communication tester	Rohde & Schwarz	CMU200	SEM010-01	2015-10-23	2016-10-23
10	Universal radio communication tester	Rohde & Schwarz	CMW500	SEM010-03	2015-10-23	2016-10-23
11	DC Power Supply	Zhao Xin	RXN-305D	SEM011-02	2015-10-09	2016-10-09
12	BiConiLog Antenna (30MHz-3GHz)	Schwarzbeck	VULB9163	SEM003-05	2015-10-17	2018-10-17
13	Horn Antenna (800MHz-18GHz)	Rohde & Schwarz	HF907	SEM003-06	2015-06-14	2018-06-14



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RF connected test						
Item	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy-mm-dd)	Cal.Due date (yyyy-mm-dd)
1	Humi/ Temp Indicator	MingGao	TH101B	W006-09	2016-03-09	2017-03-09
2	Spectrum Analyzer	Rohde & Schwarz	FSP	SEL0154	2015-10-17	2016-10-17
3	MXA Signal Analyzer	Agilent	N9020A	W025-01	2015-07-18	2016-07-18
4	Barometer	ChangChun	DYM3	SEL0088	2015-05-24	2016-05-24
5	Dual Output Mobile Communication DC Source	Agilent Technologies Inc	66319D	W009-02	2015-07-23	2016-07-23
6	Digital Multimeter	Fluke	15B+	W055-01	2016-03-09	2017-03-09
7	Wireless Communications Test Set	Rohde & Schwarz	CMW500	W005-03	2016-03-08	2017-03-08
8	Universal Radio Communication Tester	R&S	CMU200	W005-01	2015-10-23	2016-10-23

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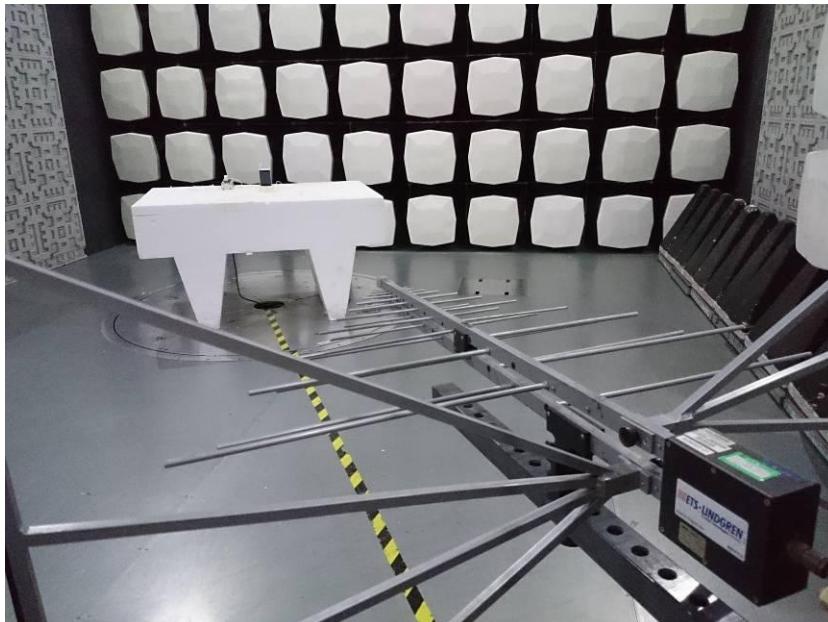
8 Measurement Uncertainty

For a 95% confidence level ($k = 2$), the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 as following:

Test Item	Extended Uncertainty	Data
Transmit Output Power Data	Power [dBm]	$U = 0.37 \text{ dB}$
Bandwidth	Magnitude [%]	$U = 0.2\%$
Band Edge Compliance	Disturbance Power [dBm]	$U = 2.0 \text{ dB}$
Spurious Emissions, Conducted	Disturbance Power [dBm]	$U = 2.0 \text{ dB}$
Field Strength of Spurious Radiation	ERP [dBm]	For 3 m Chamber: $U = 4.5 \text{ dB}$ (30 MHz to 1GHz) $U = 3.3 \text{ dB}$ (above 1 GHz) For 10 m Chamber: $U = 4.5 \text{ dB}$ (30 MHz to 1GHz) $U = 3.2 \text{ dB}$ (above 1 GHz)
Frequency Stability	Frequency Accuracy [ppm]	$U = 0.24 \text{ ppm}$

9 Photographs - EUT Test Setup

9.1 Radiated Emission



9.2 Radiated Spurious Emission



10 Photographs - EUT Constructional Details

Refer to Appendix A - Photographs of EUT Constructional Details for SZEM1603001680RG.

The End